

<b>Notice of References Cited</b>	Application/Control No. 10/743,660	Applicant(s)/Patent Under Reexamination BECK ET AL.	
	Examiner Huyen X. Vo	Art Unit 2626	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,772,109	08-2004	Tsuchitani et al.	704/2
*	B	US-6,295,134	09-2001	Hughes, Macduff R.	358/1.13
*	C	US-6,285,924	09-2001	Okamoto et al.	701/1
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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